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PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the application of:

Attorney Docket No.: 2950.54US01

BI et al.

Application No.: 10/027,906

Examiner: Unknown

Filed: December 21, 2002

Group Art Unit: 3662

For: THREE DIMENSIONAL ENGINEERING OF PLANAR OPTICAL STRUCTURES

INFORMATION DISCLOSURE STATEMENT

Assistant Commissioner for Patents
Washington, D.C. 20231

Sir:

Pursuant to 37 C.F.R. § 1.56, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached Form PTO-1449. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This information is being filed before the mailing date of a first Office Action on the merits. No certification or fee is required.

Respectfully submitted,

Peter S. Dardi

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Application No. 10/027,906

Please grant any extension of time necessary for entry; charge any fee due to Deposit Account No. 16-0631.

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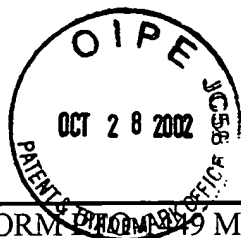
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Peter S. Dardi
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FORM 1449 MODIFIED				Docket No.: 2950.54US01		Application No.: 10/027,906	
INFORMATION DISCLOSURE CITATION IN AN APPLICATION				APPLICANT: BI et al.			
				FILING DATE: December 21, 2001			
				GROUP ART UNIT: 3662			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
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EXAMINER SIGNATURE				DATE CONSIDERED			
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FORM P-100 (REV. 11/99) MODIFIED			Docket No.: 2950.54US01		Application No.: 10/027,906	
INFORMATION DISCLOSURE CITATION IN AN APPLICATION			APPLICANT: BI et al.			
			FILING DATE: December 21, 2001			
			GROUP ART UNIT: 3662			
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EXAMINER INITIAL	DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
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FORM PTAB 9 MODIFIED INFORMATION DISCLOSURE CITATION IN AN APPLICATION				Docket No.: 2950.54US01		Application No.: 10/027,906	
				APPLICANT: BI et al.			
				FILING DATE: December 21, 2001			
				GROUP ART UNIT: 3662			
FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	
	WO 99/23189	05/1999	PCT				
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	WO 00/24093	04/2000	PCT			Abstract only	
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OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)							
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